Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/573,459	JAMES, JASON L.
Examiner	Art Unit

Hae M. Hyeon

2839

SEARCHED					
Class	Subclass	Date	Examiner		
Search	Updated	6/07	hmh		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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